

<b>Notice of References Cited</b>	Application/Control No. 10/823,513	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Satish S. Rampuria	Art Unit 2191	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0110371 A1	06-2003	Yang et al.	713/100
*	B	US-7,174,535 B2	02-2007	Wragge, Frank	717/107
*	C	US-2004/0177355 A1	09-2004	Wragge, Frank	717/174
*	D	US-2005/0005263 A1	01-2005	Miyazaki, Mitsuhiro	717/114
*	E	US-6,735,768 B1	05-2004	Tanaka, Mitsumasa	717/174
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.